



# STN2NE10

## N - CHANNEL 100V - 0.33 $\Omega$ - 2A - SOT-223 STripFET™ POWER MOSFET

PRELIMINARY DATA

| TYPE     | V <sub>DSS</sub> | R <sub>DS(on)</sub> | I <sub>D</sub> |
|----------|------------------|---------------------|----------------|
| STN2NE10 | 100 V            | < 0.4 $\Omega$      | 2 A            |

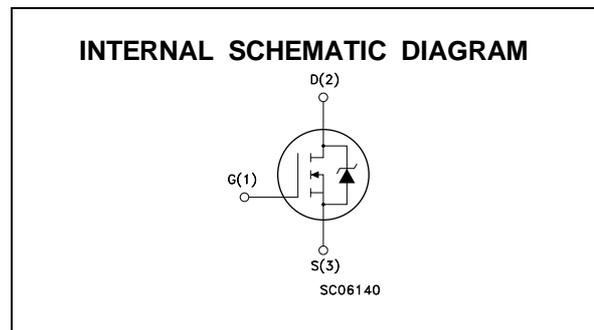
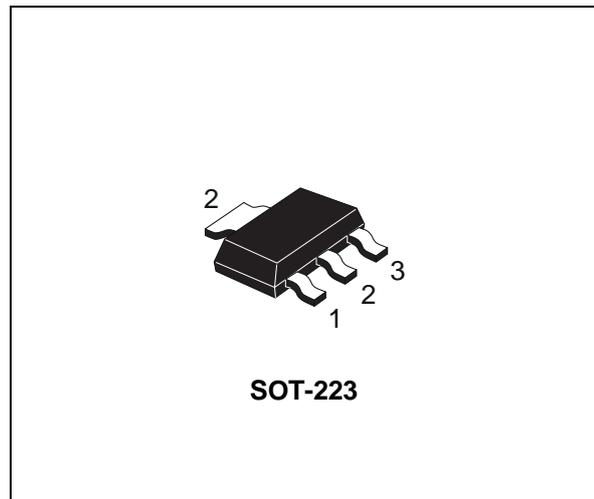
- TYPICAL R<sub>DS(on)</sub> = 0.33  $\Omega$
- EXCEPTIONAL dv/dt CAPABILITY
- AVALANCHE RUGGED TECHNOLOGY
- 100 % AVALANCHE TESTED
- APPLICATION ORIENTED CHARACTERIZATION

### DESCRIPTION

This Power Mosfet is the latest development of STMicroelectronics unique "Single Feature Size™" stip-based process. The resulting transistor shows extremely high packing density for low on-resistance, rugged avalanche characteristics and less critical alignment steps therefore a remarkable manufacturing reproducibility.

### APPLICATIONS

- DC MOTOR CONTROL (DISK DRIVES, etc.)
- DC-DC & DC-AC CONVERTERS
- SYNCHRONOUS RECTIFICATION



### ABSOLUTE MAXIMUM RATINGS

| Symbol              | Parameter  | Value      | Unit |
|---------------------|--|------------|------|
| V <sub>DS</sub>     | Drain-source Voltage (V <sub>GS</sub> = 0)             | 100        | V    |
| V <sub>DGR</sub>    | Drain- gate Voltage (R <sub>GS</sub> = 20 k $\Omega$ ) | 100        | V    |
| V <sub>GS</sub>     | Gate-source Voltage                                    | $\pm 20$   | V    |
| I <sub>D</sub>      | Drain Current (continuous) at T <sub>c</sub> = 25 °C   | 2          | A    |
| I <sub>D</sub>      | Drain Current (continuous) at T <sub>c</sub> = 100 °C  | 1.3        | A    |
| I <sub>DM</sub> (*) | Drain Current (pulsed)                                 | 8          | A    |
| P <sub>tot</sub>    | Total Dissipation at T <sub>c</sub> = 25 °C            | 2.5        | W    |
|                     | Derating Factor  | 0.02       | W/°C |
| dv/dt(1)            | Peak Diode Recovery voltage slope                      | 6          | V/ns |
| T <sub>stg</sub>    | Storage Temperature                                    | -65 to 150 | °C   |
| T <sub>j</sub>      | Max. Operating Junction Temperature                    | 150        | °C   |

(\*) Pulse width limited by safe operating area  
New RDS (on) spec. starting from JULY 98

(1) I<sub>SD</sub>  $\leq$  7 A, di/dt  $\leq$  200 A/ $\mu$ s, V<sub>DD</sub>  $\leq$  V<sub>(BR)DSS</sub>, T<sub>j</sub>  $\leq$  T<sub>JMAX</sub>

## STN2NE10

### THERMAL DATA

|                      |  |     |     |      |
|----------------------|--|-----|-----|------|
| R <sub>thj-pcb</sub> | Thermal Resistance Junction-PC Board                     | Max | 50  | °C/W |
| R <sub>thj-amb</sub> | Thermal Resistance Junction-ambient<br>(Surface Mounted) | Max | 60  | °C/W |
| T <sub>l</sub>       | Maximum Lead Temperature For Soldering Purpose           |     | 260 | °C   |

### AVALANCHE CHARACTERISTICS

| Symbol          | Parameter   | Max Value | Unit |
|-----------------|---|-----------|------|
| I <sub>AR</sub> | Avalanche Current, Repetitive or Not-Repetitive<br>(pulse width limited by T <sub>j</sub> max)                                | 2         | A    |
| E <sub>AS</sub> | Single Pulse Avalanche Energy<br>(starting T <sub>j</sub> = 25 °C, I <sub>D</sub> = I <sub>AR</sub> , V <sub>DD</sub> = 25 V) | 20        | mJ   |

### ELECTRICAL CHARACTERISTICS (T<sub>case</sub> = 25 °C unless otherwise specified)

OFF

| Symbol               | Parameter   | Test Conditions  | Min. | Typ. | Max.    | Unit     |
|----------------------|---|--|------|------|---------|----------|
| V <sub>(BR)DSS</sub> | Drain-source Breakdown Voltage                        | I <sub>D</sub> = 250 μA V <sub>GS</sub> = 0  | 100  |      |         | V        |
| I <sub>DSS</sub>     | Zero Gate Voltage Drain Current (V <sub>GS</sub> = 0) | V <sub>DS</sub> = Max Rating<br>V <sub>DS</sub> = Max Rating T <sub>c</sub> = 125 °C |      |      | 1<br>10 | μA<br>μA |
| I <sub>GSS</sub>     | Gate-body Leakage Current (V <sub>DS</sub> = 0)       | V <sub>GS</sub> = ± 20 V   |      |      | ± 100   | nA       |

ON (\*)

| Symbol              | Parameter                         | Test Conditions   | Min. | Typ. | Max. | Unit |
|---------------------|-----------------------------------|---|------|------|------|------|
| V <sub>GS(th)</sub> | Gate Threshold Voltage            | V <sub>DS</sub> = V <sub>GS</sub> I <sub>D</sub> = 250 μA                               | 2    | 3    | 4    | V    |
| R <sub>DS(on)</sub> | Static Drain-source On Resistance | V <sub>GS</sub> = 10 V I <sub>D</sub> = 1A  |      | 0.33 | 0.4  | Ω    |
| I <sub>D(on)</sub>  | On State Drain Current            | V <sub>DS</sub> > I <sub>D(on)</sub> × R <sub>DS(on)max</sub><br>V <sub>GS</sub> = 10 V | 2    |      |      | A    |

### DYNAMIC

| Symbol              | Parameter                    | Test Conditions  | Min. | Typ. | Max. | Unit |
|---------------------|------------------------------|--|------|------|------|------|
| g <sub>fs</sub> (*) | Forward Transconductance     | V <sub>DS</sub> > I <sub>D(on)</sub> × R <sub>DS(on)max</sub> I <sub>D</sub> = 1 A | 1    | 1.8  |      | S    |
| C <sub>iSS</sub>    | Input Capacitance            | V <sub>DS</sub> = 25 V f = 1 MHz V <sub>GS</sub> = 0 V                             |      | 305  |      | pF   |
| C <sub>oSS</sub>    | Output Capacitance           |  |      | 45   |      | pF   |
| C <sub>rSS</sub>    | Reverse Transfer Capacitance |  |      | 21   |      | pF   |

**ELECTRICAL CHARACTERISTICS** (continued)**SWITCHING ON**

| Symbol      | Parameter          | Test Conditions  | Min. | Typ. | Max. | Unit |
|-------------|--------------------|--|------|------|------|------|
| $t_{d(on)}$ | Turn-on Delay Time | $V_{DD} = 50\text{ V}$ $I_D = 35\text{ A}$<br>$R_G = 4.7\ \Omega$ $V_{GS} = 10\text{ V}$<br>(Resistive Load, see fig. 3) |      | 7    |      | ns   |
| $t_r$       | Rise Time          |  |      | 17   |      | ns   |
| $Q_g$       | Total Gate Charge  | $V_{DD} = 80\text{ V}$ $I_D = 7\text{ A}$ $V_{GS} = 10\text{ V}$   |      | 14   | 19   | nC   |
| $Q_{gs}$    | Gate-Source Charge |  |      | 6    |      | nC   |
| $Q_{gd}$    | Gate-Drain Charge  |  |      | 4    |      | nC   |

**SWITCHING OFF**

| Symbol        | Parameter             | Test Conditions   | Min. | Typ. | Max. | Unit |
|---------------|-----------------------|---|------|------|------|------|
| $t_{d(off)}$  | Turn-off Delay Time   | $V_{DD} = 50\text{ V}$ $I_D = 3.5\text{ A}$<br>$R_G = 4.7\ \Omega$ $V_{GS} = 10\text{ V}$<br>(Resistive Load, see fig. 3)   |      | 25   |      | ns   |
| $t_f$         | Fall Time             |   |      | 7    |      | ns   |
| $t_{r(Voff)}$ | Off-voltage Rise Time | $V_{clamp} = 16\text{ V}$ $I_D = 80\text{ A}$<br>$R_G = 4.7\ \Omega$ $V_{GS} = 10\text{ V}$<br>(Inductive Load, see fig. 5) |      | 7    |      | ns   |
| $t_f$         | Fall Time             |   |      | 8    |      | ns   |
| $t_c$         | Cross-over Time       |   |      | 16   |      | ns   |

**SOURCE DRAIN DIODE**

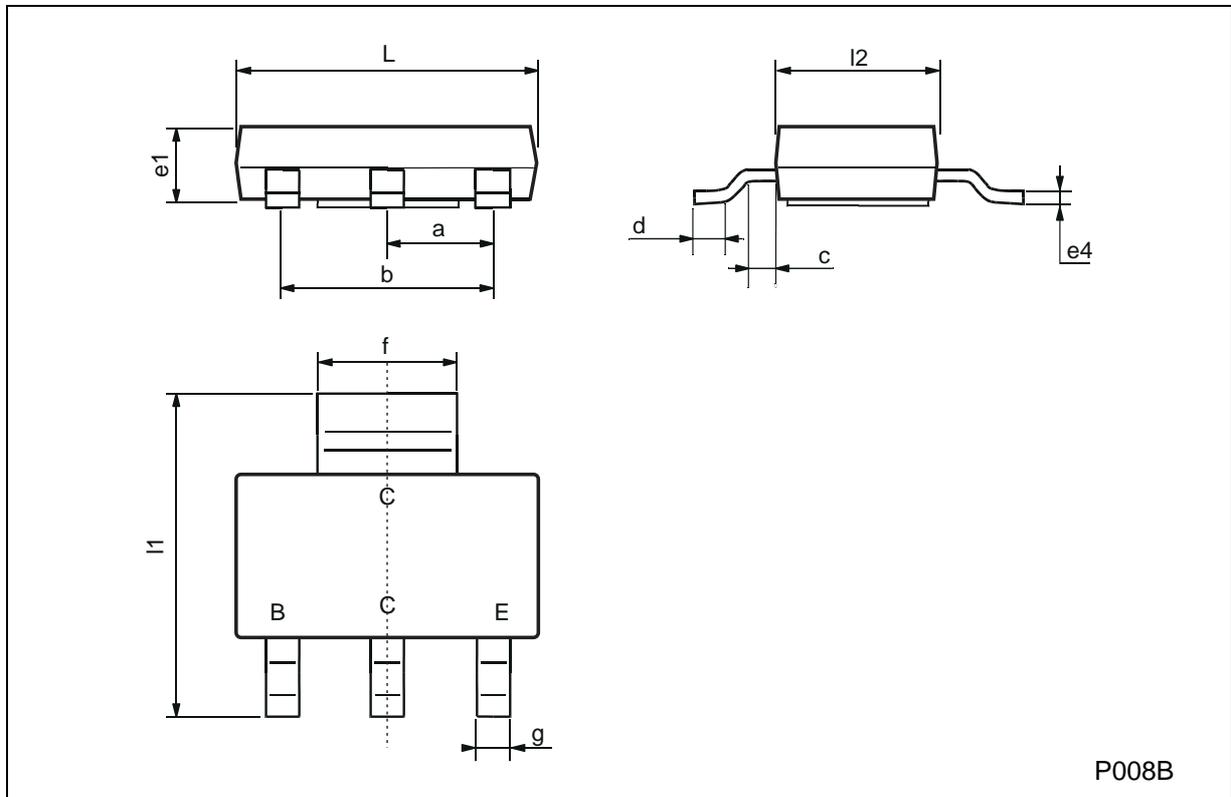
| Symbol             | Parameter                     | Test Conditions  | Min. | Typ. | Max. | Unit          |
|--------------------|-------------------------------|--|------|------|------|---------------|
| $I_{SD}$           | Source-drain Current          |  |      |      | 2    | A             |
| $I_{SDM}(\bullet)$ | Source-drain Current (pulsed) |  |      |      | 8    | A             |
| $V_{SD} (*)$       | Forward On Voltage            | $I_{SD} = 2\text{ A}$ $V_{GS} = 0$   |      |      | 1.5  | V             |
| $t_{rr}$           | Reverse Recovery Time         | $I_{SD} = 7\text{ A}$ $di/dt = 100\text{ A}/\mu\text{s}$<br>$V_{DD} = 30\text{ V}$<br>(see test circuit, fig. 5) |      | 75   |      | ns            |
| $Q_{rr}$           | Reverse Recovery Charge       |  |      | 210  |      | $\mu\text{C}$ |
| $I_{RRM}$          | Reverse Recovery Current      |  |      | 5.5  |      | A             |

(\*) Pulsed: Pulse duration = 300  $\mu\text{s}$ , duty cycle 1.5 %

(\bullet) Pulse width limited by safe operating area

**SOT-223 MECHANICAL DATA**

| DIM. | mm   |      |      | mils  |       |       |
|------|------|------|------|-------|-------|-------|
|      | MIN. | TYP. | MAX. | MIN.  | TYP.  | MAX.  |
| a    | 2.27 | 2.3  | 2.33 | 89.4  | 90.6  | 91.7  |
| b    | 4.57 | 4.6  | 4.63 | 179.9 | 181.1 | 182.3 |
| c    | 0.2  | 0.4  | 0.6  | 7.9   | 15.7  | 23.6  |
| d    | 0.63 | 0.65 | 0.67 | 24.8  | 25.6  | 26.4  |
| e1   | 1.5  | 1.6  | 1.7  | 59.1  | 63    | 66.9  |
| e4   |      |      | 0.32 |       |       | 12.6  |
| f    | 2.9  | 3    | 3.1  | 114.2 | 118.1 | 122.1 |
| g    | 0.67 | 0.7  | 0.73 | 26.4  | 27.6  | 28.7  |
| l1   | 6.7  | 7    | 7.3  | 263.8 | 275.6 | 287.4 |
| l2   | 3.5  | 3.5  | 3.7  | 137.8 | 137.8 | 145.7 |
| L    | 6.3  | 6.5  | 6.7  | 248   | 255.9 | 263.8 |



P008B

Information furnished is believed to be accurate and reliable. However, STMicroelectronics assumes no responsibility for the consequences of use of such information nor for any infringement of patents or other rights of third parties which may result from its use. No license is granted by implication or otherwise under any patent or patent rights of STMicroelectronics. Specification mentioned in this publication are subject to change without notice. This publication supersedes and replaces all information previously supplied. STMicroelectronics products are not authorized for use as critical components in life support devices or systems without express written approval of STMicroelectronics.

The ST logo is a trademark of STMicroelectronics

© 1998 STMicroelectronics – Printed in Italy – All Rights Reserved

STMicroelectronics GROUP OF COMPANIES

Australia - Brazil - Canada - China - France - Germany - Italy - Japan - Korea - Malaysia - Malta - Mexico - Morocco - The Netherlands - Singapore - Spain - Sweden - Switzerland - Taiwan - Thailand - United Kingdom - U.S.A.

<http://www.st.com>